

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/554,265 | | Applicant(s)/Patent Under Reexamination OSE ET AL. | |
| | Examiner Saeed T. Chaudhry | | Art Unit 1792 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-5,213,118 | 05-1993 | Kamikawa, Yuji | 134/62 |
| * | B | US-6,016,819 | 01-2000 | Murray et al. | 134/64R |
| * | C | US-2002/0007844 | 01-2002 | Orii et al. | 134/30 |
| * | D | US-2002/0020435 | 02-2002 | Varpio, Timo | 134/18 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| * | N | 2001156034 | 06-2001 | Japan | | |
| * | O | 2003017459 | 01-2003 | Japan | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.